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Application/Control No.	Applicant(s)/Patent under Reexamination
10/661,451	GEE ET AL.
Examiner	Art Unit

David J. Venci

1641

SEARCHED					
Class	Subclass	Date	Examiner		
435	7.1,7.7,7.7 2,288.7,96 4,DIG.41	6/12/2006	DV		
435	DIG.42	6/12/2006	DV		
436	546,120	6/12/2006	DV		
436	172,800	6/12/2006	DV		
548	335.1	8/8/2007	DV		
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST/WEST .	6/12/2006	DV		
PUBMED	6/12/2006	DV		
SCIENCEDIRECT	6/12/2006	DV .		
PALM - inventor name search	6/12/2006	DV		
updated	8/8/2007	DV		
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